	Application/Control No.	Applicant(s)/Patent Under Reexamination
Issue Classification	10684445	BAIK, KWANG JUN
	Examiner	Art Unit
	Lamb, Christopher R	2627

	Lamb, Christopher R	2627		
ORIGINAL	AL	INTERNATIONA	INTERNATIONAL CLASSIFICATION	
CLASS	SUBCLASS	CLAIMED	NON-CLAIMED	AIMED
969	53.21	G 1 1 B 7/00		
CROSS REFERENCE(S)	RENCE(S)			
CLASS (ONE SUBCLASS	E SUBCLASS PER BLOCK)			
		-		
Christopher Lamb 11/21/06 CR				
	WILLIAM KORZIICH	BANCH	otal Claims Allowed:	s Allowed:
(Assistant Examiner) (Date)	SUPERVISORY PATENT EXAMINER	INT EXAMINER	16	(0
19/9/P	TECHNOLOGY CENTER 2600	NTER 2600	O.G. Print Claim(s)	O.G. Print Figure
(Legal Instruments Examiner) (Date)	(Primary Examiner)	(Date)	-	4

U.S. Patent and Trademark Office